Applicant(s)/Patent Under Application/Control No. Reexamination 10/708,807 TOKARZ ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1742 Deborah Yee **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 72/200 US-5,771,731 06-1998 Rohde et al. Α 148/541 US-6,030,470 02-2000 Hensger et al. В 148/541 С US-6,231,696 05-2001 Hensger et al. US-D US-Ε US-F US-G US-Н US-١ US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Ţ **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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